Search	1 Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/707,275	CHOU, HUI-KAI	
Examiner	Art Unit	•
Thuy V Tran	2821	

SEARCHED				
Class	Subclass	Date	Examiner	
	updated	11/9/2006	Т.Т.	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

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